Electromagnetic Wave Scattering from Rough Layered Interfaces: Analysis with the Small Perturbation Method and the Small Slope Approximation

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Abstract—We propose a theoretical study on the electromagnetic wave scattering from layered structures with an arbitrary number of rough interfaces by using the small perturbation method and the small slope approximation. The interfaces are characterized by Gaussian height distributions with zero mean values and Gaussian correlation functions. They can be correlated or not. The electromagnetic field in each medium is represented by a Rayleigh expansion and a perturbation method is used for solving the boundary value problem and determining the first-order scattering amplitudes by recurrence relations. The scattering amplitude under the first-order small slope approximation are deduced from results derived from the first-order small perturbation method. Comparison between these two analytical models and a numerical method based on the combination of scattering matrices is presented.

1. INTRODUCTION

The study of electromagnetic wave scattering from rough layered interfaces has many applications in remote sensing, communication techniques, civil engineering, geophysics and optics. Several models give the average scattered field and the average intensity. Analytical methods are based on physical approximations and give closed-form formulae for the first- and second-order moments of the scattered field. Exact methods estimate the average scattered field and the average intensity from the results over many realizations of rough layered interfaces. In this paper, we propose a theoretical study on the electromagnetic wave scattering from layered structures with an arbitrary number of rough interfaces by using two analytical models: the first-order small perturbation method (SPM) and the first-order small slope approximation (SSA).

Elson was one of the first authors to develop a vector theory of scattering from a stratified medium. This vector theory allows the angular distribution of scattered light to be determined and can be used with correlated or uncorrelated surface roughness [1,2]. The SPM has been used for the study of light scattering from multilayer optical coatings [1–5] and many authors have also implemented a perturbative theory for analyzing remote sensing problems [6–12]. The small slope approximation (SSA1) has an extended domain of applicability [13–15] which includes the domain of the small-perturbation method that is only valid for surfaces with small roughness [16] and the domain of the Kirchhoff approximation that is applicable to surfaces with long correlation length [17, 18].

In the present paper, the structure under consideration is a stack of several rough one-dimensional interfaces. The interfaces are characterized by Gaussian height distributions with zero mean values and Gaussian correlation functions. The electromagnetic field in each region is represented by a continuous spectrum of plane waves, the amplitudes of which are found by matching the boundary conditions

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for both interfaces. The boundary value problem is imposed up to the first-order and the scattering amplitudes are derived from recurrence relations [6]. The scattering amplitudes under the first-order small slope approximation are deduced from results derived from the first-order small perturbation method. We establish the closed-form formulae for the coherent and incoherent intensities of the electromagnetic wave scattering from layered structures. In [14], the authors extended the SSA to the fourth-order terms of the perturbative development and studied a slab with uncorrelated rough two-dimensional interfaces. In the present paper, we consider the first-order SSA method applied to an arbitrary number of one-dimensional interfaces. Moreover, the interfaces can be uncorrelated, partially or fully correlated. To our knowledge, this is a novelty. We also compare these two methods with each other and with a Rayleigh-Fourier method extended to multilayer structures and based on the combination of elementary scattering matrices of different interfaces [19, 20].

2. STATISTICAL DESCRIPTION OF INTERFACES

The geometry of the structure is described in Figure 1. We consider a stack of several rough onedimensional interfaces. These surfaces are randomly deformed over a length L. For the study with both analytical models, L will be extended to infinity. Both interfaces i and i + 1 are separated by a layer with thickness $d_i = u_{i+1} - u_i$ (with $u_1 = 0$). N designates the number of media.

Each interface is a Gaussian random process, centered $(\langle a_i(x) \rangle = 0, \forall x)$ and stationary to the second order. Henceforth, the angular brackets $\langle \rangle$ stand for statistical averages. The random interfaces are uncorrelated, partially or fully correlated. We denote $R_{ii}(x)$ the autocorrelation function associated with the interface *i* and $R_{ij}(x)$, the cross-correlation function between the interfaces *i* and *j*. The random functions $a_i(x)$ are obtained by filtering of uncorrelated white noises $b_j(x)$:

$$a_i(x) = h_i(x) * \sum_{j=1}^{N-1} p_{ij} b_j(x)$$
(1)

where

$$\sum_{j=1}^{N-1} p_{ij}^2 = 1 \tag{2}$$

The symbol * designates the convolution operation. The functions $h_i(x)$ are the impulse responses of Gaussian filters defined by:

 $h_i(x) = \sigma_i \sqrt{\frac{2}{\sqrt{\pi}l_i}} \exp\left(-\frac{2x^2}{l_i^2}\right)$ (3)

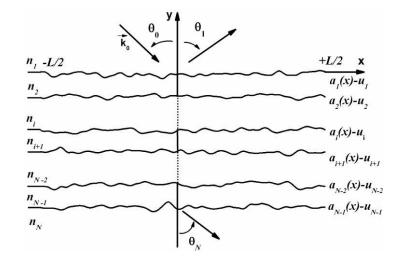


Figure 1. Structure with several nonparallel one-dimensional interfaces.

The autocorrelation (i = j) and cross-correlation $(i \neq j)$ functions are expressed as follows:

$$R_{ij}(x) = \left\langle a_i(x')a_j(x+x') \right\rangle = q_{ij} \int_{-\infty}^{+\infty} h_i(x')h_j(x+x')dx' \tag{4}$$

where

$$q_{ij} = \sum_{k=1}^{N-1} p_{ik} p_{jk}$$
(5)

According to (3), we have:

$$R_{ij}(x) = q_{ij}\sigma_i\sigma_j\sqrt{\frac{2l_il_j}{l_i^2 + l_j^2}} \exp\left(-\frac{2x^2}{l_i^2 + l_j^2}\right)$$
(6)

 σ_i is the rms height of the interface *i* and l_i the correlation length. If $q_{i,j\neq i} = 0$, the interfaces *i* and *j* are uncorrelated. They are fully correlated for $l_i = l_j$ and $q_{ij} = \pm 1$. They are partially correlated in other cases. According to (6), the roughness spectra of interfaces (i = j) and their cross-spectral density $(i \neq j)$ are given by:

$$\hat{R}_{ij}(\alpha) = \operatorname{FT}\left[R_{ij}(x)\right] = \int_{-\infty}^{+\infty} R_{ij}(x) \exp(+j\alpha x) dx = q_{ij}\sigma_i\sigma_j\sqrt{\pi l_i l_j} \exp\left[-\alpha^2 \frac{(l_i^2 + l_j^2)}{8}\right]$$
(7)

Thereafter, the letters FT designate the Fourier Transform operation.

3. INCIDENT FIELD AND SCATTERED FIELDS

The structure is illuminated by a monochromatic plane wave with a wavelength λ and a harmonic temporal dependence $\exp(j\omega t)$. The incident wave vector \vec{k}_0 is located in the xOy plane and forms the angle θ_0 with the Oy axis. Medium 1 is assimilated to the vacuum. Z is the vacuum impedance and $k = 2\pi/\lambda$, the wave number. Henceforth, ε_{ri} , n_i , Z_i and k_i designate the relative permittivity, the optical index $(n_i = \sqrt{\varepsilon_{ri}})$, the impedance $(Z_i = Z/n_i)$ and the wave number $(k_i = n_i k)$ of the layer *i*. Let $F_0(x, y)$ the Oz-component of the incident field of amplitude A_0 :

$$F_0(x,y) = A_0 \exp\left[-j\left(\alpha_0 x - \beta_0 y\right)\right] \tag{8}$$

 α_0 and β_0 are the propagation coefficients with $\alpha_0^2 + \beta_0^2 = k^2$. For the polarization $E_{//}$, the electric field vector is parallel to the Oz axis and $F_0(x, y) = E_{0z}(x, y)$. For the polarization $H_{//}$, it is the magnetic field vector which is parallel to the Oz axis and $F_0(x, y) = Z_1 H_{0z}(x, y)$.

In each medium, the scattered field is represented by a continuous spectrum of plane waves, commonly called Rayleigh expansion. In medium 1, the Oz-component is given as follows:

$$F_1(x,y) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} A_1(\alpha) \exp\left[-j\left(\alpha x + \beta_1 y\right)\right] d\alpha \tag{9}$$

In medium i with $2 \le i \le N-1$, it is necessary to consider upwards and downwards propagating waves.

$$F_{i}(x,y) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} A_{i}^{(-)}(\alpha) \exp\left[-j\left(\alpha x - \beta_{i}y\right)\right] d\alpha$$
$$+ \frac{1}{2\pi} \int_{-\infty}^{+\infty} A_{i}^{(+)}(\alpha) \exp\left[-j\left(\alpha x + \beta_{i}y\right)\right] d\alpha$$
(10)

In the lower medium N, the Rayleigh expansion is represented by downwards propagating waves:

$$F_N(x,y) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} A_N(\alpha) \exp\left[-j\left(\alpha x - \beta_N y\right)\right] d\alpha \tag{11}$$

Each plane wave is characterized by its wave function $\exp(-j(\alpha x \pm \beta_i y))$ and its wave vector $\vec{k}_i^{(\mp)} = \alpha \vec{u}_x \mp \beta_i \vec{u}_y$. The scattering amplitudes $A_i^{(\mp)}(\alpha)$ represent the unknowns of the problem. The propagation coefficients β_i $(1 \le i \le N)$ present a negative or zero imaginary part with $\beta_i^2 + \alpha^2 = k_i^2$. The propagation coefficients β_i associated with α_0 are denoted $\beta_{i0} = \beta_i(\alpha_0)$. The magnetic components in polarization $E_{//}$ and the electric components in polarization $H_{//}$ are deduced from the orthogonality relations between the electric vector, the magnetic vector and the wave vector of the elementary plane waves of the Rayleigh integrals defined by (9)-(11).

The normalized bistatic scattering coefficient is defined by the power scattered per unit angle divided by the flux of incident power through the modulated region of length L. In the upper medium, we have [16]:

$$I(\theta) = \frac{|A_1(\alpha = k\sin\theta)|^2 \cos^2\theta}{\lambda\cos\theta_0 L |A_0|^2}$$
(12)

In the case of scattering from randomly rough interfaces, $A_1(k\sin\theta)$ is a random function of the observation angle θ . We can write this function as a sum of an average amplitude $\langle A_1 \rangle$ and a fluctuating amplitude defined by $A_1 - \langle A_1 \rangle$. The average amplitude gives the coherent intensity $I_C(\theta)$ by substituting A_1 by $\langle A_1 \rangle$ into (12) and the fluctuating amplitude gives the incoherent intensity with $I_f(\theta) = \langle I(\theta) \rangle - I_C(\theta)$. $\langle I(\theta) \rangle$ represents the bi-static scattering coefficient. Within the framework of the small perturbation method and the small slope approximation, we consider interfaces with an infinite extension and we define the coherent and incoherent intensities from analytical calculations. With a numerical method, the intensities are estimated over results of several interface realizations of finite extension.

4. THE SMALL PERTURBATION METHOD (SPM)

4.1. The Rayleigh Hypothesis and the Boundary Condition Problem

The Rayleigh hypothesis is compatible with the Rayleigh expansion at any point of the space including the interfaces [21–24]. This hypothesis makes it possible to write the boundary conditions which stipulate the continuity of the electric and magnetic components parallel to the interfaces. The scattering amplitudes $A_i^{(\mp)}(\alpha)$ satisfy the following equations:

$$e_i [F_i(x,y)]_{y=a_i(x)-u_i} = [F_{i+1}(x,y)]_{y=a_i(x)-u_i}$$
(13)

$$\left[\frac{\partial F_i(x,y)}{\partial y} - \dot{a}_i(x)\frac{\partial F_i(x,y)}{\partial x}\right]_{y=a_i(x)-u_i} = e_i \left[\frac{\partial F_{i+1}(x,y)}{\partial y} - \dot{a}_i(x)\frac{\partial F_{i+1}(x,y)}{\partial x}\right]_{y=a_i(x)-u_i}$$
(14)

where

$$e_{i} = \begin{cases} 1 & \text{in } E_{//} \\ n_{i}/n_{i+1} & \text{in } H_{//} \end{cases}$$
(15)

We determine the scattering amplitudes $A_1(\alpha)$, $A_i^{(\pm)}(\alpha)$ and $A_N(\alpha)$ within the framework of the firstorder small perturbation method applied to the boundary value problem (13)–(14). The perturbation method consists in representing the scattering amplitudes and the elementary wave functions by expansions in entire series [1].

4.2. Zeroth- and First-order Small Perturbation Method

The zeroth-order problem gives the field scattered by a stack of perfectly smooth interfaces [1, 2, 25]. The zeroth-order boundary value problem on the interface *i* leads to the following matrix system,

$$\begin{bmatrix} A_i^{(+,0)}(\alpha_0) \\ A_i^{(-,0)}(\alpha_0) \end{bmatrix} = \mathbf{C}_{(i,i+1)}(\alpha_0) \begin{bmatrix} A_{i+1}^{(+,0)}(\alpha_0) \\ A_{i+1}^{(-,0)}(\alpha_0) \end{bmatrix}$$
(16)

where for the polarization $E_{//}$, the matrix $\mathbf{C}_{(i,i+1)}(\alpha)$ (here at the value $\alpha = \alpha_0$) is given by

$$\mathbf{C}_{(i,i+1)E_{//}}(\alpha) = \begin{pmatrix} \frac{\beta_i + \beta_{i+1}}{2\beta_i} \exp[+j\left(\beta_{i+1} - \beta_i\right)u_i] & \frac{\beta_i - \beta_{i+1}}{2\beta_i} \exp[-j\left(\beta_{i+1} + \beta_i\right)u_i] \\ \frac{\beta_i - \beta_{i+1}}{2\beta_i} \exp[+j\left(\beta_{i+1} + \beta_i\right)u_i] & \frac{\beta_i + \beta_{i+1}}{2\beta_i} \exp[-j\left(\beta_{i+1} - \beta_i\right)u_i] \end{pmatrix}$$
(17)

and for the polarization $H_{//}$, by

$$\mathbf{C}_{(i,i+1)H_{//}}(\alpha) = \begin{pmatrix} \frac{n_{i+1}^2 \beta_i + n_i^2 \beta_{i+1}}{2n_i n_{i+1} \beta_i} \exp[+j(\beta_{i+1} - \beta_i)u_i] & \frac{n_{i+1}^2 \beta_i - n_i^2 \beta_{i+1}}{2n_i n_{i+1} \beta_i} \exp[-j(\beta_{i+1} + \beta_i)u_i] \\ \frac{n_{i+1}^2 \beta_i - n_i^2 \beta_{i+1}}{2n_i n_{i+1} \beta_i} \exp[+j(\beta_{i+1} + \beta_i)u_i] & \frac{n_{i+1}^2 \beta_i - n_i^2 \beta_{i+1}}{2n_i n_{i+1} \beta_i} \exp[-j(\beta_{i+1} - \beta_i)u_i] \end{pmatrix}$$
(18)

The product $\mathbf{M}_{1,N}(\alpha_0)$ of N-1 matrices $\mathbf{C}_{(i,i+1)}(\alpha_0)$ yields the overall transfer matrix from medium N to medium 1.

$$\begin{bmatrix} A_1^{(0)}(\alpha_0) \\ A_0(\alpha_0) \end{bmatrix} = \mathbf{M}_{1,N}(\alpha) \begin{bmatrix} 0 \\ A_N^{(0)}(\alpha_0) \end{bmatrix} = \begin{bmatrix} M_{1,N}^{(+,+)}(\alpha_0) & M_{1,N}^{(+,-)}(\alpha_0) \\ M_{1,N}^{(-,+)}(\alpha_0) & M_{1,N}^{(-,-)}(\alpha_0) \end{bmatrix} \begin{bmatrix} 0 \\ A_N^{(0)}(\alpha_0) \end{bmatrix}$$
(19)

where

$$\mathbf{M}_{1,N}(\alpha_0) = \prod_{i=1}^{N-1} \mathbf{C}_{(i,i+1)}(\alpha_0)$$
(20)

We find from (19) the reflection coefficient $A_1^{(0)}(\alpha_0)$ and the transmission coefficient $A_N^{(0)}(\alpha_0)$ as follows:

$$A_1^{(0)}(\alpha_0) = \frac{M_{1,N}^{(+,-)}(\alpha_0)}{M_{1,N}^{(-,-)}(\alpha_0)} A_0(\alpha_0)$$
(21)

$$A_N^{(0)}(\alpha_0) = \frac{1}{M_{1,N}^{(-,-)}(\alpha_0)} A_0(\alpha_0)$$
(22)

The amplitudes of plane waves reflected and transmitted within the layer i (with $2 \le i \le N-1$) are deduced from relationships (16) and (20):

$$\begin{bmatrix} A_i^{(+,0)}(\alpha_0) \\ A_i^{(-,0)}(\alpha_0) \end{bmatrix} = \frac{\mathbf{M}_{i,N}(\alpha_0)}{M_{1,N}^{(-,-)}(\alpha_0)} \begin{bmatrix} 0 \\ A_0(\alpha_0) \end{bmatrix} = \frac{1}{M_{1,N}^{(-,-)}(\alpha_0)} \begin{bmatrix} M_{i,N}^{(+,-)}(\alpha_0) \\ M_{i,N}^{(-,-)}(\alpha_0) \end{bmatrix} A_0(\alpha_0)$$
(23)

Taking into account Eqs. (8)–(11) and the zeroth-order solutions, the first-order boundary value problem (13)–(15) on the interface *i* leads to the following matrix system:

$$\begin{bmatrix} A_i^{(+,1)}(\alpha) \\ A_i^{(-,1)}(\alpha) \end{bmatrix} = \mathbf{C}_{(i,i+1)}(\alpha) \begin{bmatrix} A_{i+1}^{(+,1)}(\alpha) \\ A_{i+1}^{(-,1)}(\alpha) \end{bmatrix} = +j\hat{a}_i(\alpha - \alpha_0) \left(n_i^2 - n_{i+1}^2\right) \mathbf{D}_{(i)}(\alpha) \begin{bmatrix} A_{i+1}^{(+,0)}(\alpha_0) \\ A_{i+1}^{(-,0)}(\alpha_0) \end{bmatrix}$$
(24)

where $\hat{a}_i(\alpha)$ is the Fourier Transform (FT) of the function $a_i(x)$ describing the interface *i*. The matrix $\mathbf{C}_{(i,i+1)}(\alpha)$ is given by (17) for the polarization $E_{//}$ and by (18) for the polarization $H_{//}$, respectively. The matrices $\mathbf{D}_{(i)}(\alpha)$ are expressed as follows:

$$\mathbf{D}_{(i)E_{//}}(\alpha) = \begin{pmatrix} \frac{k_0^2}{2\beta_i} \exp\left[-j\left(\beta_i - \beta_{i+10}\right)u_i\right] & \frac{k_0^2}{2\beta_i} \exp\left[-j\left(\beta_i + \beta_{i+10}\right)u_i\right] \\ -\frac{k_0^2}{2\beta_i} \exp\left[+j\left(\beta_i + \beta_{i+10}\right)u_i\right] & -\frac{k_0^2}{2\beta_i} \exp\left[+j\left(\beta_i - \beta_{i+10}\right)u_i\right] \end{pmatrix}$$
(25)
$$\mathbf{D}_{(i)H_{//}}(\alpha) = \begin{pmatrix} \frac{\alpha_0\alpha + \beta_i\beta_{i+10}}{2n_in_{i+1}\beta_i} \exp\left[-j\left(\beta_i - \beta_{i+10}\right)u_i\right] & \frac{\alpha_0\alpha - \beta_i\beta_{i+10}}{2n_in_{i+1}\beta_i} \exp\left[-j\left(\beta_i + \beta_{i+10}\right)u_i\right] \\ -\frac{\alpha_0\alpha - \beta_i\beta_{i+10}}{2n_in_{i+1}\beta_i} \exp\left[+j\left(\beta_i + \beta_{i+10}\right)u_i\right] & -\frac{\alpha_0\alpha + \beta_i\beta_{i+10}}{2n_in_{i+1}\beta_i} \exp\left[+j\left(\beta_i - \beta_{i+10}\right)u_i\right] \end{pmatrix}$$
(26)

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Substituting (23) into (24), we find:

$$\begin{bmatrix} A_i^{(+,1)}(\alpha) \\ A_i^{(-,1)}(\alpha) \end{bmatrix} = \mathbf{C}_{(i,i+1)}(\alpha) \begin{bmatrix} A_{i+1}^{(+,1)}(\alpha) \\ A_{i+1}^{(-,1)}(\alpha) \end{bmatrix} + j \left(n_i^2 - n_{i+1}^2 \right) \hat{a}_i(\alpha - \alpha_0) \begin{bmatrix} N_i^{(+)} \\ N_i^{(-)} \end{bmatrix} A_0(\alpha_0)$$
(27)

where

$$\begin{bmatrix} N_i^{(+)} \\ N_i^{(-)} \end{bmatrix} = \frac{1}{M_{1,N}^{(-,-)}(\alpha_0)} \begin{bmatrix} D_{(i)}^{(+,+)} M_{i+1,N}^{(+,-)}(\alpha_0) + D_{(i)}^{(-,-)} M_{i+1,N}^{(-,-)}(\alpha_0) \\ D_{(i)}^{(-,+)} M_{i+1,N}^{(+,-)}(\alpha_0) + D_{(i)}^{(-,-)} M_{i+1,N}^{(-,-)}(\alpha_0) \end{bmatrix}$$
(28)

Using recursively the relationship (28), we obtain for the first-order scattering amplitudes the transfer matrix from medium N to medium i:

$$\begin{bmatrix} A_i^{(+,1)}(\alpha) \\ A_i^{(-,1)}(\alpha) \end{bmatrix} = \begin{bmatrix} M_{i,N}^{(+,-)}(\alpha) \\ M_{i,N}^{(-,-)}(\alpha) \end{bmatrix} A_N^{(1)}(\alpha) + j \sum_{j=i}^{N-1} \left(n_j^2 - n_{j+1}^2 \right) \hat{a}_j(\alpha - \alpha_0) \begin{bmatrix} S_{i,j}^{(+)} \\ S_{i,j}^{(-)} \end{bmatrix} A_0(\alpha_0)$$
(29)

where

$$\begin{bmatrix} S_{i,j}^{(+)} \\ S_{i,j}^{(-)} \end{bmatrix} = \begin{bmatrix} N_j^{(+)} M_{i,j}^{(+,+)}(\alpha) + N_j^{(-)} M_{i,j}^{(+,-)}(\alpha) \\ N_j^{(+)} M_{i,j}^{(-,+)}(\alpha) + N_j^{(-)} M_{i,j}^{(-,-)}(\alpha) \end{bmatrix}$$
(30)

Applying (29) with i = 1, we deduce the first-order scattered amplitudes $A_1^{(1)}(\alpha)$ and $A_N^{(1)}(\alpha)$ as follows

$$A_{1}^{(1)}(\alpha) = j \sum_{j=1}^{N-1} (n_{j}^{2} - n_{j+1}^{2}) \hat{a}_{j}(\alpha - \alpha_{0}) \left[S_{1,j}^{(+)} - \frac{M_{1,N}^{(+,-)}(\alpha)}{M_{1,N}^{(-,-)}(\alpha)} S_{1,j}^{(-)} \right] A_{0}(\alpha_{0})$$
(31)

$$A_N^{(1)}(\alpha) = -\frac{j}{M_{1,N}^{(-,-)}(\alpha)} \sum_{j=1}^{N-1} \left(n_j^2 - n_{j+1}^2 \right) \hat{a}_j(\alpha - \alpha_0) S_{1,j}^{(-)} A_0(\alpha_0)$$
(32)

Finally, substituting (32) into (29), we obtain the first-order solutions for the medium i (with $2 \le i \le N-1$):

$$\begin{bmatrix} A_{i}^{(+,1)}(\alpha) \\ A_{i}^{(-,1)}(\alpha) \end{bmatrix} = \frac{jA_{0}(\alpha_{0})}{M_{1,N}^{(-,-)}(\alpha)} \begin{pmatrix} \sum_{j=i}^{N-1} \left(n_{j}^{2} - n_{j+1}^{2}\right) \hat{a}_{j}(\alpha - \alpha_{0}) \begin{bmatrix} M_{1,N}^{(-,-)}(\alpha)S_{i,j}^{(+)} - M_{i,N}^{(+,-)}(\alpha)S_{1,j}^{(-)} \\ M_{1,N}^{(-,-)}(\alpha)S_{i,j}^{(-)} - M_{i,N}^{(-,-)}(\alpha)S_{1,j}^{(-)} \end{bmatrix} \\ -\sum_{j=1}^{i-1} \left(n_{j}^{2} - n_{j+1}^{2}\right) \hat{a}_{j}(\alpha - \alpha_{0}) \begin{bmatrix} M_{i,N}^{(+,-)}(\alpha) \\ M_{i,N}^{(-,-)}(\alpha) \end{bmatrix} S_{1,j}^{(-)} \end{pmatrix}$$
(33)

Analytical expressions of the scattering amplitudes are given in Reference [16] for a single surface separating two homogeneous media and in Reference [10], for two interfaces delimiting three layers.

4.3. Coherent Intensity and Incoherent Intensity

The Oz-component of the scattered field takes the following form:

$$F_{1,SPM}(x,y) = \frac{1}{2\pi} \int_{-\infty}^{+\infty} A_{1,SPM}^{(1)}(\alpha) \exp(-j\alpha x - j\beta y) d\alpha$$
(34)

where

$$A_{1,SPM}^{(1)}(\alpha) = 2\pi A_1^{(0)}(\alpha_0)\delta(\alpha - \alpha_0) + A_1^{(1)}(\alpha)$$
(35)

The Fresnel coefficient $A_1^{(0)}(\alpha_0)$ of the plane wave reflected by the unperturbed structure is given by (21) and the first-order scattering amplitude $A_1^{(1)}(\alpha)$ by (31). We write the first-order scattering amplitude as follows:

$$A_1^{(1)}(\alpha) = A_0(\alpha_0) \sum_{i=1}^{N-1} K_i(\alpha) \,\hat{a}_i(\alpha - \alpha_0)$$
(36)

According to (31), the complex amplitudes $K_i(\alpha)$ is given by:

$$K_{i}(\alpha) = j \left(n_{i}^{2} - n_{i+1}^{2} \right) \left(S_{1,i}^{(+)}(\alpha) - \frac{M_{1,N}^{(+,-)}(\alpha)}{M_{1,N}^{(-,-)}(\alpha)} S_{1,i}^{(-)}(\alpha) \right)$$
(37)

For interfaces with infinite extension, we find from (12) and (35) that the coherent intensity I_C^{SPM} and the incoherent intensity I_f^{SPM} are given by [10]:

$$I_C^{SPM}(\theta) = \frac{\cos\theta_0}{\lambda} \left| A_1^{(0)}(k\sin\theta_0) \right|^2 2\pi\delta(k\sin\theta - k\sin\theta_0)$$
(38)

$$I_f^{SPM} = \frac{\cos^2 \theta}{\lambda \cos \theta_0} \left\{ \sum_{n=1}^{N-1} |K_n|^2 \, \hat{R}_{nn}(k \sin \theta - k \sin \theta_0) + \operatorname{Re} \left[\sum_{n=1}^{N-1} \sum_{\substack{m=1\\n \neq m}}^{N-1} K_n K_m^* \hat{R}_{nm}(k \sin \theta - k \sin \theta_0) \right] \right\} (39)$$

The coherent intensity is in the specular direction and the incoherent intensity depends on spectra and cross-spectra of interfaces by an affine relationship.

5. THE SMALL SLOPE APPROXIMATION METHOD (SSA)

5.1. Expression of the Scattering Amplitude

The SSA is based on the invariance properties of the scattering amplitude. Performing a horizontal or vertical translation d on the structure only affects the latter by a phase shift $\exp(+j(\alpha - \alpha_0)d)$ or $\exp(+j(\beta_1 + \beta_0)d)$, respectively [13]. So, for a stack of several interfaces, a solution of the first-order scattering amplitude is sought in the form:

$$A_{1,SSA}^{(1)}(\alpha,\alpha_0) = A_0(\alpha_0) \sum_{i=1}^{N-1} \frac{K_i(\alpha,\alpha_0)}{j(\beta_1 + \beta_0)} \int_{-\infty}^{+\infty} \exp(j(\alpha - \alpha_0)x) \exp[j(\beta_1 + \beta_0)a_i(x)] dx$$
(40)

Using the Dirac delta function identity,

$$\int_{-\infty}^{+\infty} \exp(j(\alpha - \alpha_0)x) dx = 2\pi\delta(\alpha - \alpha_0)$$
(41)

we show that when $a_i(x) \to 0$ and $L \to \infty$, the solution (40) is consistent with the first-order SPM if

$$A_1^{(0)}(\alpha_0) = \frac{A_0(\alpha_0) \sum_{i=1}^{N-1} K_i(\alpha_0, \alpha_0)}{2j\beta_0}$$
(42)

From the analytical expressions given in references [10, 16], we checked the formula (42) for one (N = 2) and two interfaces (N = 3). For $N \ge 4$, we have to check this relationship by a numerical calculation.

5.2. Coherent and Incoherent Intensities with the SSA Method

The bistatic scattering coefficient is defined as follows:

$$\left\langle I^{SSA}(\theta) \right\rangle = \lim_{L \to +\infty} \frac{\left\langle \left| A_{1,SSA}^{(1)}(\alpha) \right|^2 \right\rangle \cos^2 \theta}{\lambda L \cos \theta_0 \left| A_0 \right|^2} \tag{43}$$

with $\alpha = k \sin \theta$. Substituting (40) into (43), we obtain:

$$\left\langle I^{SSA}(\theta) \right\rangle = \frac{\cos^2 \theta}{\lambda \cos \theta_0 (\beta_1 + \beta_0)^2} \times \sum_{n=1}^{N-1} \sum_{m=1}^{N-1} K_n(\alpha, \alpha_0) K_m^*(\alpha, \alpha_0)$$
$$\lim_{L \to +\infty} \frac{1}{L} \int_{-L/2 - L/2}^{+L/2 + L/2} \exp\left(j\left(\alpha - \alpha_0\right) \left(x' - x''\right)\right) M_{nm} dx' dx'' \tag{44}$$

where $\alpha_0 = k \sin \theta_0$, $\beta_0 = k \cos \theta_0$, $\beta_1 = k \cos \theta$ and,

$$M_{nm} = \left\langle \exp[j(\beta_1 + \beta_0) \left(a_n(x') - a_m(x'') \right)] \right\rangle$$
(45)

The SSA model requires the knowledge of the two-point height probability distribution. For Gaussian height distribution, the cross-correlation term M_{nm} is expressed as follows:

$$M_{nm} = \exp\left(-\frac{\sigma_n^2 + \sigma_m^2}{2}(\beta_1 + \beta_0)^2\right) \exp\left((\beta_1 + \beta_0)^2 R_{nm}\left(x' - x''\right)\right)$$
(46)

By using the change of variables x = x' - x'' and y = x', we find:

$$\langle I_{SSA}(\theta) \rangle = \frac{\cos^2 \theta}{\lambda \cos \theta_0 (\beta_1 + \beta_0)^2} \sum_{n=1}^{N-1} \sum_{m=1}^{N-1} K_n(\alpha) K_m^*(\alpha) \exp\left(-\frac{\sigma_n^2 + \sigma_m^2}{2} (\beta_1 + \beta_0)^2\right) N_{nm}$$
(47)

where

$$N_{nm} = \lim_{L \to +\infty} \int_{-L}^{+L} T(x) \exp\left(j(\alpha - \alpha_0)x\right) \exp\left((\beta_1 + \beta_0)^2 R_{nm}(x)\right) dx \tag{48}$$

T(x) is a triangular function defined by:

$$T(x) = \begin{cases} 1 - \frac{|x|}{L} & \text{for } |x| < L\\ 0 & \text{elsewhere} \end{cases}$$
(49)

For correlation functions having a finite memory $(\lim_{x \to +\infty} R_{nm}(x) = 0)$, N_{nm} may be written as:

$$N_{nm} = 2\pi\delta(\alpha - \alpha_0) + \sum_{q=1}^{+\infty} \frac{k^2(\cos\theta + \cos\theta_0)^{2q}}{q!} \operatorname{FT}\left[R_{nm}^q(x)\right]\left(k\sin\theta - k\sin\theta_0\right)$$
(50)

where the substitutions (51) and (52) have been made.

$$\exp\left((\beta_1 + \beta_0)^2 R_{nm}(x)\right) = 1 + \sum_{q=1}^{+\infty} R_{nm}^q(x) \frac{(\beta_1 + \beta_0)^{2q}}{q!}$$
(51)

$$\lim_{L \to +\infty} \int_{-L}^{+L} T(x) \exp\left(j(\alpha - \alpha_0)x\right) dx = 2\pi\delta(\alpha - \alpha_0)$$
(52)

The first term $2\pi\delta(\alpha - \alpha_0)$ of the sum defining N_{nm} leads to the coherent intensity:

$$I_C^{SSA}(\theta) = \frac{1}{4\lambda k^2 \cos \theta_0} \left| \sum_{i=1}^{N-1} K_i(k\sin \theta_0, k\sin \theta_0) \exp\left(-2(k\cos \theta_0)^2 \sigma_i^2\right) \right|^2 2\pi \delta(k\sin \theta - k\sin \theta_0) \quad (53)$$

The second term gives the incoherent intensity as:

$$I_f^{SSA}(\theta) = \frac{\cos^2 \theta}{\lambda k^2 \cos \theta_0 (\cos \theta + \cos \theta_0)^2} \times \sum_{n=1}^{N-1} \sum_{m=1}^{N-1} K_n(k \sin \theta) K_m^*(k \sin \theta) P_{nm}(\theta)$$
$$\exp\left(-k^2 \frac{\sigma_n^2 + \sigma_m^2}{2} (\cos \theta + \cos \theta_0)^2\right) \tag{54}$$

with

$$P_{nm}(\theta) = \sum_{q=1}^{+\infty} \frac{k^2 (\cos\theta + \cos\theta_0)^{2q}}{q!} \operatorname{FT}\left[R_{nm}^q(x)\right] (k\sin\theta - k\sin\theta_0)$$
(55)

As the zeroth-order SPM-solution, the coherent intensity $I_C^{\text{SSA}}(\theta)$ is also in the specular direction but it depends on the root mean square roughness heights and does not depend on the shape of correlation functions. The incoherent intensity $I_f^{\text{SSA}}(\theta)$ depends on the rms-roughness heights and on the Fourier Transforms (FT) of the correlation functions $R_{nm}(x)$ to the power q. For this reason, the applicability domains of the SSA model for Gaussian correlation functions and for exponential functions are different. In this paper, we only consider Gaussian correlation functions and the conclusions obtained from simulations cannot be applied to rough surfaces with an exponential correlation function for which the rms-slope is not defined.

For Gaussian auto and cross-correlation functions, we find:

$$\operatorname{FT}\left[R_{nm}^{q}(x)\right](\alpha) = \left(q_{nm}\sigma_{n}\sigma_{m}\sqrt{\frac{2l_{n}l_{m}}{l_{n}^{2}+l_{m}^{2}}}\right)^{q}\sqrt{\frac{\pi(l_{n}^{2}+l_{m}^{2})}{2q}}\exp\left(-\frac{(l_{n}^{2}+l_{m}^{2})\alpha^{2}}{8q}\right)$$
(56)

6. THE FOURIER-RAYLEIGH METHOD FOR A LAYERED STRUCTURE

A main aim of the paper is to compare the SPM and SSA methods with each other. In order to illustrate that the domain of applicability of the SSA method is more extended, we compare both analytical methods with a Rayleigh-Fourier method extended to multi-layer structures and based on the combination of elementary scattering matrices of different interfaces [19, 20]. The Rayleigh-Fourier method has been used for the study of diffraction gratings [21] and rough surfaces [22–24]. The scattered field is expanded as a series of plane wave, the scattering amplitudes of which are derived from the boundary value problem.

For each medium $(1 \le i \le N)$, the field is represented by a series of upwards and downwards plane waves.

$$F_{i}(x,y) = \sum_{n} A_{i,n}^{(-)} \exp\left[-j\left(\alpha_{n}x - \beta_{i,n}y\right)\right] + \sum_{n} A_{i,n}^{(+)} \exp\left[-j\left(\alpha_{n}x + \beta_{i,n}y\right)\right]$$
(57)

with $\alpha_n = \alpha_0 + n2\pi/L$, $\beta_{i,n}^2 + \alpha_n^2 = k_i^2$ and $\text{Im}[\beta_{i,n}] \leq 0$. By comparison (57) with (10), we can identify $A_{i,n}^{(\pm)}$ with $A_i^{(\pm)}(\alpha_n)/L$. The generalized scattering matrix relates the outgoing plane wave amplitudes to the incoming ones. For the interface i $(1 \leq i \leq N - 1)$, we write:

$$\begin{pmatrix} \vec{A}_i^{(+)} \\ \vec{A}_{i+1}^{(-)} \end{pmatrix} = \begin{bmatrix} \mathbf{S}_{i \leftrightarrow i+1}^{(+,-)} & \mathbf{S}_{i \leftrightarrow i+1}^{(+,+)} \\ \mathbf{S}_{i \leftrightarrow i+1}^{(-,-)} & \mathbf{S}_{i \leftrightarrow i+1}^{(-,+)} \end{bmatrix} \begin{bmatrix} \vec{A}_i^{(-)} \\ \vec{A}_i^{(+)} \\ \vec{A}_{i+1} \end{bmatrix}$$
(58)

The vector $\vec{A}_i^{(\pm)}$ contains the scattering amplitudes $A_{i,n}^{(\pm)}$. The scattering matrix $\mathbf{S}_{i \leftrightarrow i+1}$ associated with the interface *i* is represented by the four sub-matrices $\mathbf{S}_{i \leftrightarrow i+1}^{(\pm)}$. We derive these matrices by projecting the

boundary relationships (13)–(14) on functions $\exp(-j\alpha_n x)$. The numerical solution requires a truncation order M. It is then assumed that the outgoing and incoming fields are well described by only 2M + 1wave functions $\exp[-j(\alpha_n x \pm \beta_{i,n} y)]$. As a result, $\mathbf{S}_{i \leftrightarrow i+1}$ is a 4M + 2-dimensional square matrix. The overall scattering matrix $\mathbf{S}_{1 \leftrightarrow N}$ of the layered structure is obtained from cascading elementary scattering matrices $\mathbf{S}_{i \leftrightarrow i+1}$ [19, 20] as follows:

$$\mathbf{S}_{i\leftrightarrow i+2}^{(+,-)} = \mathbf{S}_{i\leftrightarrow i+1}^{(+,-)} + \mathbf{S}_{i\leftrightarrow i+1}^{(+,+)} \left[\mathbf{I} - \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \right]^{-1} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \mathbf{S}_{i\leftrightarrow i+1}^{(-,-)} \\ \mathbf{S}_{i\leftrightarrow i+2}^{(+,+)} = \mathbf{S}_{i\leftrightarrow i+1}^{(+,+)} \left[\mathbf{I} - \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \right]^{-1} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,+)} \\ \mathbf{S}_{i\leftrightarrow i+2}^{(-,-)} = \mathbf{S}_{i+1\leftrightarrow i+2}^{(-,-)} \left[\mathbf{I} - \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \right]^{-1} \mathbf{S}_{i\leftrightarrow i+1}^{(-,-)} \\ \mathbf{S}_{i\leftrightarrow i+2}^{(-,+)} = \mathbf{S}_{i+1\leftrightarrow i+2}^{(-,+)} + \mathbf{S}_{i+1\leftrightarrow i+2}^{(-,-)} \left[\mathbf{I} - \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \right]^{-1} \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \mathbf{S}_{i\leftrightarrow i+1}^{(+,+)} \\ \mathbf{S}_{i\leftrightarrow i+2}^{(-,+)} = \mathbf{S}_{i+1\leftrightarrow i+2}^{(-,+)} + \mathbf{S}_{i+1\leftrightarrow i+2}^{(-,-)} \left[\mathbf{I} - \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,-)} \right]^{-1} \mathbf{S}_{i\leftrightarrow i+1}^{(-,+)} \mathbf{S}_{i+1\leftrightarrow i+2}^{(+,+)} \end{aligned}$$
(59)

I is the identity matrix. With this numerical method, the intensities are estimated over results of several interface realizations of finite extension.

The Rayleigh-Fourier method implicitly assumes that the structure is periodic in x with period L. The periodicity of the structure gives rise to supplementary electromagnetic couplings that do not exist in the case of surfaces of infinite length. These artificial couplings are important for a lossless medium where the wave propagation within a layer is easier. But, it is not the case for the analyzed structures that are characterized by complex-valued relative permittivities. So, if the period is sufficiently large, the Rayleigh-Fourier method can be used to estimate the coherent and incoherent intensities. For the structure under consideration, the convergence on the values of intensities is obtained for interface lengths greater than 20 wavelengths.

7. NUMERICAL RESULTS

For all simulations, we consider the scattering of electromagnetic waves from a stack of three randomly rough interfaces. These interfaces are characterized by Gaussian auto-correlation and cross-correlation functions with the correlation lengths $l_1 = 0.3\lambda$, $l_2 = 0.4\lambda$ and $l_3 = 0.5\lambda$ and they are separated by two layers with thickness $d_1 = 0.35\lambda$ and $d_2 = 0.25\lambda$. The values of relative permittivity are fixed at $\varepsilon_{r2} = 6.26 - 0.52j$, $\varepsilon_{r2} = 8.45 - 0.85j$ and $\varepsilon_{r4} = 11.3 - 1.27j$. These values correspond to soil moistures with volumetric content of 15%, 20% and 25%, respectively [26]. The frequency is in band L and the wavelength is equal to 20 cm. We consider two configurations of rms-heights: $\sigma_1 = 0.036\lambda$, $\sigma_2 = 0.027\lambda$, $\sigma_3 = 0.0225\lambda$ and $\sigma_1 = 0.060\lambda$, $\sigma_2 = 0.045\lambda$, $\sigma_3 = 0.0375\lambda$. For both configurations, $\sigma_2 = 3\sigma_1/4$ and $\sigma_3 = 5\sigma_1/8$.

The Rayleigh-Fourier method is applied with $L = 40\lambda$ and M = 140. The number of realizations N_r is equal to 600. The Rayleigh-Fourier method becomes unstable with increasing of the number of plane waves and with increasing of surface roughness [22–24]. We did not observe any numerical problem with the used simulation parameters.

Figure 2(a) shows the coherent intensity for the first configuration under both polarizations and Figure 2(b) gives the curves for the second configuration. For both configurations, the interfaces are uncorrelated with $q_{i,j\neq i} = 0$. The curves show that the coherent intensity is higher in polarization $E_{//}$. For both configurations, we notice the Brewster phenomenon in the polarization $H_{//}$ and the coherent intensity becomes smaller under $\theta_{Brewster} = 68.2^{\circ}$. Under normal incidence, the SPM method gives the same value under both polarizations. It's likewise with the SSA model. For the Rayleigh-Fourier method, the coherent intensity under normal incidence depends on the polarization. This result is caused by the anisotropy of one-dimensional surfaces. The differences between the SPM and SSA results increase when increasing the interface roughness and decrease when increasing the incidence angle. Comparison between the SSA model and the Rayleigh-Fourier method is conclusive for the first configuration and satisfactory for the second configuration. The differences are slightly more marked under $H_{//}$ -incidence. For the analysed structure where $\sigma_2 = 3\sigma_1/4$ and $\sigma_3 = 5\sigma_1/8$, the SSA model allows describing the coherent intensity when the rms-height σ_1 is smaller about 0.06λ . This value corresponds to rough interfaces with slopes of less than 28%.

Figure 3(a) shows the backscattered intensity for the first configuration under both polarizations and Figure 3(b) gives results for the second configuration. For both configurations, the interfaces are uncorrelated. The curves show that the backscattered intensity is higher in polarization $H_{//}$. For both configurations, we do not notice effects of the Brewster phenomenon under the polarization $H_{//}$. Under normal incidence, the SPM method gives the same value under both polarizations. It is likewise with the SSA model. The differences between the SPM and SSA results increase when increasing the interface roughness. Comparison between the SSA model and the Rayleigh-Fourier method is conclusive for the first configuration and satisfactory for the second configuration. For the second configuration, the SSA method underestimates the numerical method results in polarization $E_{//}$ and overestimates results in polarization $H_{//}$. For the studied configurations where $\sigma_2 = 3\sigma_1/4$ and $\sigma_3 = 5\sigma_1/8$, the SSA model allows describing the backscattered intensity when the rms-height σ_1 is smaller than 0.06 λ . This limit value is empirical and obtained by comparison with the Rayleigh-Fourier method results. It can change from one structure to another according to the permittivity and layer thickness values. The SPM model applied with $\sigma_1 = 0.06\lambda$ does not allow a satisfactory prediction of the backscattered coefficient. The SPM model gives a satisfactory estimation for heights twice smaller.

Figure 4(a) gives the incoherent intensity obtained with the three methods for the second configuration under the polarization $E_{//}$. Figure 4(b) shows curves in polarization $H_{//}$. The incidence

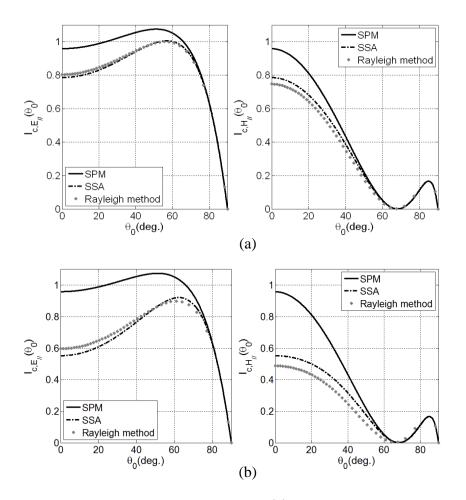


Figure 2. Coherent intensity versus incidence angle for (a) the first configuration and (b) the second configuration.

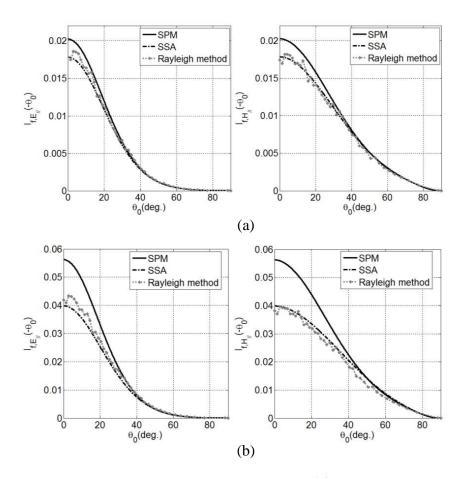


Figure 3. Backscattered intensity versus incidence angle for (a) the first configuration and (b) the second configuration.

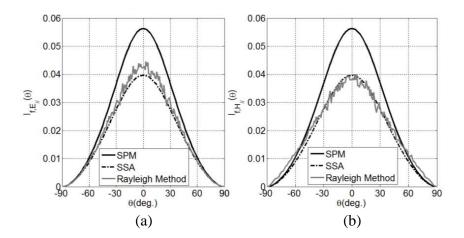


Figure 4. Incoherent intensity with the three methods for the second configuration under (a) $E_{//}$ -polarization and (b) $H_{//}$ -polarization.

angle θ_0 is fixed at 0° and the interfaces are partially correlated with a mixing matrice p_{ij} as follows:

$$p_{ij} = \begin{pmatrix} 1/\sqrt{3} & 1/\sqrt{3} & 1/\sqrt{3} \\ 0 & 1/\sqrt{2} & 1/\sqrt{2} \\ 0 & 0 & 1 \end{pmatrix}$$
(60)

According to (5), the parameters q_{ij} are defined by:

$$q_{ij} = \begin{pmatrix} 1 & 2/\sqrt{6} & 1/\sqrt{3} \\ 2/\sqrt{6} & 1 & 1/\sqrt{2} \\ 1/\sqrt{3} & 1/\sqrt{2} & 1 \end{pmatrix}$$
(61)

Comparison between the SSA model and the Rayleigh-Fourier method is satisfactory for both polarizations. The SSA model underestimates the numerical method results in polarization $E_{//}$ and overestimates results in polarization $H_{//}$. The SPM model does not allow a satisfactory prediction of the incoherent intensity.

8. CONCLUSION

In this paper, we considered the electromagnetic wave scattering from layered structures with an arbitrary number of rough interfaces. First, we applied a perturbation method on the boundary value problem and determined the scattering amplitudes in each medium from recurrence relations. Second, the scattering amplitudes under the first-order small slope approximation are deduced from results derived from the first-order small perturbation method. In final, we determined the closed-form formulae for the coherent and incoherent intensities in the air. The SPM only requires the knowledge of roughness spectra of interfaces and their cross-spectral density. The SSA model requires the knowledge of the correlation and of the two-point height probability distribution. We considered Gaussian height distributions.

We studied configurations with three interfaces. The differences between the coherent intensities obtained from the SPM and SSA models increase when increasing the interface roughness and decrease when increasing the incidence angle. It is likewise observed on the incoherent intensities. We compared the SPM and SSA models with a Rayleigh-Fourier method based on the combination of elementary scattering matrices of different interfaces. For the analyzed structures, we showed that the SSA model can describe the coherent and incoherent intensities for heights twice higher than those obtained by the SPM model.

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